

Notice of References Cited		Application/Control No. 10/573,975	Applicant(s)/Patent Under Reexamination BIENAS ET AL.	
		Examiner FRANK DONADO	Art Unit 2617	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,287,200 B1	09-2001	Sharma, Dipanshu	463/40
*	B	US-2002/0137526 A1	09-2002	Shinohara, Masahito	455/456
*	C	US-2002/0175855 A1	11-2002	Richton et al.	342/357.02
*	D	US-2003/0129977 A1	07-2003	Dolwin, Anthony Craig	455/422
*	E	US-2003/0186710 A1	10-2003	Muhonen et al.	455/456.5
*	F	US-2004/0214584 A1	10-2004	Marinier, Paul	455/456.1
*	G	US-2005/0099942 A1	05-2005	Kurihara, Kuniaki	370/229
*	H	US-7,151,939 B2	12-2006	Sheynblat, Leonid	455/456.1
*	I	US-7,197,322 B1	03-2007	Rayburn et al.	455/456.1
J	US-				
K	US-				
L	US-				
M	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	I					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.